

2N3866(A)

NPN SILICON LOW POWER TRANSISTORS

High-reliability discrete products and engineering services since 1977

FEATURES

- Available as "HR" (high reliability) screened per MIL-PRF-19500, JANTX level. Add "HR" suffix to base part number.
- Available as non-RoHS (Sn/Pb plating), standard, and as RoHS by adding "-PBF" suffix.

MAXIMUM RATINGS

| Parameters | Symbol | Value | Unit |
|---|-----------------------------------|-------------|-------|
| Collector-Emitter Voltage | V _{CEO} | 30 | V |
| Collector-Base Voltage | V _{CB} | 55 | V |
| Emitter-Base Voltage | V _{EB} | 3.5 | V |
| Collector Current - Continuous | lc | 0.400 | А |
| Total Power Dissipation @ T _A = 25°C | D | 5.0 | W |
| Derate Above 25°C | PD | 28.6 | mW/°C |
| Operating and Storage Temperature Range | T _J , T _{stg} | -65 to +200 | °C |

ELECTRICAL CHARACTERISTICS (T_c = 25°C unless otherwise specified)

| Parameters | | Symbol | Min | Тур | Max | Unit |
|---|---------|----------------------|-----|-----|-----|--------|
| OFF CHARACTERISTICS | | | | | | |
| Collector-Emitter Breakdown Voltage | | B\/ore | 55 | _ | _ | V |
| I _C = 5.0mA, R _{BE} = 10Ω | | D V CER | 55 | - | - | v |
| Collector-Emitter Sustaining Voltage | | BVcro | 30 | _ | - | V |
| I _C = 5.0mA, I _B = 0 | | DVCEO | 50 | | _ | v |
| Collector-Base Breakdown Voltage | | BVcno | 55 | _ | _ | V |
| I _E = 0, I _C = 0.1mA | | DVCBO | 55 | | _ | v |
| Emitter-Base Breakdown Voltage | | B \/ | 35 | _ | | V |
| I _E = 0.1mA, I _C = 0 | | DVEBO | 5.5 | | _ | v |
| Collector Cutoff Current | | Icro. | _ | _ | 20 | μΑ |
| $V_{CE} = 28V, I_B = 0$ | | ICEO | | _ | | |
| Collector Cutoff Current | | lenv | _ | _ | 100 | ıιΔ |
| V _{CE} = 55V, V _{BE} = 1.5V | | ICEX | | | 100 | μ |
| ON CHARACTERISTICS | | | | | | |
| DC Current Gain | | | | | | |
| Ic = 360mA, V _{CE} = 5V | 2N3866 | | FO | | | |
| | 2N3866A | | 5.0 | - | - | |
| I _C = 0.05A, V _{CE} = 5V | 2N3866 | NFE | 10 | - | 200 | - |
| $I_{c} = 50 mA$, $V_{ce} = 5 V$ | 2N3866A | | 25 | - | 200 | |
| Collector-Emitter Saturation Voltage | | V _{CE(sat)} | | - | 1.0 | v |
| I _C = 100mA, I _B = 20mA | | | - | | | |
| DYNAMIC CHARACTERISTICS | | | | | | |
| Current Gain – Bandwidth Product | 2N3866 | f | 500 | 800 | - | NAL I- |
| I_{C} = 50mA, V_{CE} = 15V, f = 200MHz | 2N3866A | ΤŢ | 800 | - | - | IVIHZ |
| Output Capacitance | | <u> </u> | _ | 2.0 | 2.0 | nE |
| V _{CB} = 30V, I _E = 0, f = 1.0MHz | | Cob | - | 2.0 | 3.0 | рг |



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| Parameters | | Symbol | Min | | Max | Unit | |
|----------------------|--|--------|-----|---|-----|------|--|
| FUNCTIONAL TEST | | | | | | | |
| Power Gain | Test circuit – Figure 1 Pin = 0.1W, V = 28V, f = 400MHz, T = 25° C | Gpe | 10 | - | - | dB | |
| Power Output | | Pout | 1.0 | - | - | W | |
| Collector Efficiency | 1 = 0.144, 4 = 204, 1 = 4000002, 10 = 25 C | ŋ | 45 | - | - | % | |

MECHANICAL CHARACTERISTICS

| Case | ТО-39 |
|----------|---------------|
| Marking | Alpha-numeric |
| Polarity | See below |



| | TO-39 | | | | |
|---|---------|-------|-------------|-------|--|
| | Inc | hes | Millimeters | | |
| | Min | Max | Min | Max | |
| Α | 0.350 | 0.370 | 8.890 | 9.400 | |
| В | 0.315 | 0.335 | 8.000 | 8.510 | |
| С | 0.240 | 0.260 | 6.10 | 6.60 | |
| D | 0.016 | 0.021 | 0.406 | 0.533 | |
| Е | 0.009 | 0.125 | 0.2269 | 3.180 | |
| F | 0.016 | 0.019 | 0.406 | 0.533 | |
| G | 0.190 | 0.210 | 4.830 | 5.33 | |
| Н | 0.028 | 0.034 | 0.711 | 0.864 | |
| J | 0.029 | 0.040 | 0.737 | 1.020 | |
| К | 0.500 | - | 12.700 | - | |
| L | 0.250 | - | 6.350 | | |
| М | 45° NOM | | 45° N | MON | |
| Р | - | 0.050 | - | 1.270 | |
| Q | 90° | MOM | 90° N | MON | |
| R | 0.100 | | 2.540 | - | |





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400 MHz RF AMPLIFIER CIRCUIT FOR POWER-OUTPUT TEST